

<b>Notice of References Cited</b>	Application/Control No. 10/688,561		Applicant(s)/Patent Under Reexamination BURKE ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,661,748	05-1972	Blackmer, David E.	204/401
*	B	US-4,812,210	03-1989	Bonivert et al.	205/787
*	C	US-5,583,432	12-1996	Barnes, Christopher	324/204
*	D	US-5,650,061	07-1997	Kuhr et al.	205/775
*	E	US-5,753,101	05-1998	Ludwig, Frank A.	205/781
*	F	US-6,096,186	08-2000	Warburton, P. Richard	205/782
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	03/019166	03-2003	WO	Kastebo et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	Niewiadomski, W. et al, Physics in Medicine and Biology 1990, 35,1575-1583.			
	V	Cha, K. et al, Physiological measurement 1994, 15, 2, 129-137.			
	W	Olthof, C. G. et al, Medical and Biological Engineering and Computing 1994, 32, 495-500.			
	X	Maasrani, M. et al, Medical & biological engineering & computing 1997. 35, 3, 167-171.			

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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**U.S. PATENT DOCUMENTS**

* A B C D E F G H I J K L M	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	US-			
	US-			
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	US-			
	US-			
	US-			

**FOREIGN PATENT DOCUMENTS**

* N O P Q R S T	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification

**NON-PATENT DOCUMENTS**

* U V W X	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	Luo, R. et al, Industrial & Engineering Chemistry Research 1998, 37, 1024-1032.
	Jaffrin, M. Y. et al, Medical and Biological Engineering and Computing 1999, 37, 433-439.
	Ying, C.-M. et al, Industrial & Engineering Chemistry Research 2000, 39, 396-407.
	Engblom, S. O. et al, Journal of Electroanalytical Chemistry 2000, 480, 120-132.

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Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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N					
O					
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	Brevnov, D. A. et al, Journal of Electroanalytical Chemistry 2000, 488, 133-139.
V	Li, W. et al, Journal of Process Control 2002, 12, 429-443.
W	
X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.